

# TC7WZ125FK

## 1. Functional Description

- Dual Bus Buffer with 3-State Output

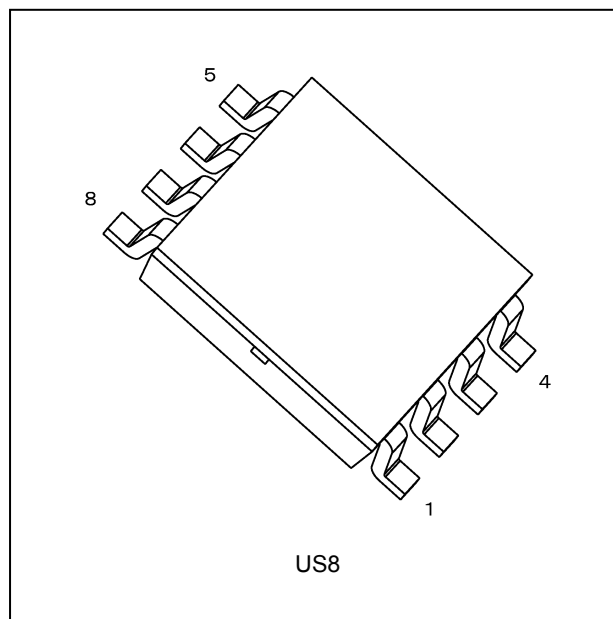
## 2. Features

- (1) AEC-Q100 (Rev. H) (Note 1)
- (2) Wide operating temperature range:  $T_{opr} = -40$  to  $125$  °C (Note 2)
- (3) High output current:  $\pm 24$  mA (min) at  $V_{CC} = 3.0$  V
- (4) Super high speed operation:  $t_{pd} = 2.6$  ns (typ.) at  $V_{CC} = 5.0$  V,  $C_L = 50$  pF
- (5) Operation voltage range:  $V_{CC} = 1.65$  to  $5.5$  V
- (6) 5.5 V tolerant inputs
- (7) 5.5 V power down protection output
- (8) Matches the performance of TC74LCX series when operated at  $3.3$  V  $V_{CC}$

Note 1: This device is compliant with the reliability requirements of AEC-Q100. For details, contact your Toshiba sales representative.

Note 2: For devices with the ordering part number ending in J(CT).  $T_{opr} = -40$  to  $85$  °C for the other devices.

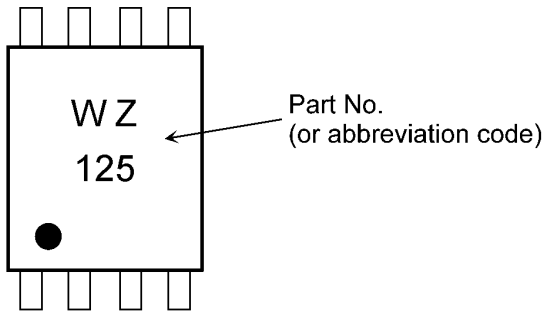
## 3. Packaging



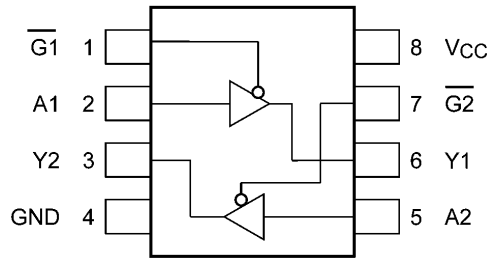
Start of commercial production

2009-09

**4. Marking and Pin Assignment**

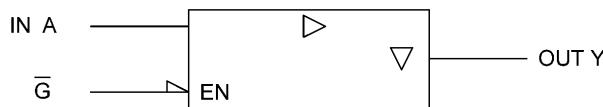


**Marking**



**Pin Assignment (Top view)**

**5. IEC Logic Symbol**



**6. Truth Table**

Input A	Input $\bar{G}$	Output Y
X	H	Z
L	L	L
H	L	H

X: Don't care  
Z: High impedance

**7. Absolute Maximum Ratings (Note) (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	$V_{CC}$		-0.5 to 6.0	V
Input voltage	$V_{IN}$		-0.5 to 6.0	V
DC output voltage	$V_{OUT}$	(Note 1)	-0.5 to 6.0	V
		(Note 2)	-0.5 to $V_{CC} + 0.5$	
Input diode current	$I_{IK}$		-20	mA
Output diode current	$I_{OK}$	(Note 3)	-20	mA
DC output current	$I_{OUT}$		$\pm 50$	mA
$V_{CC}$ /ground current	$I_{CC}$		$\pm 50$	mA
Power dissipation	$P_D$		200	mW
Storage temperature	$T_{stg}$		-65 to 150	$^\circ\text{C}$

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1:  $V_{CC} = 0\text{ V}$  or high impedance condition

Note 2: High (H) or Low (L) state.  $I_{OUT}$  absolute maximum rating must be observed.

Note 3:  $V_{OUT} < \text{GND}$

## 8. Operating Ranges (Note)

Characteristics	Symbol	Note	Test Condition	Rating	Unit
Supply voltage	$V_{CC}$		—	1.65 to 5.5	V
		(Note 1)	—	1.5 to 5.5	
Input voltage	$V_{IN}$		—	0 to 5.5	V
Output voltage	$V_{OUT}$	(Note 2)	—	0 to 5.5	V
		(Note 3)	—	0 to $V_{CC}$	
Operating temperature	$T_{opr}$	(Note 4)	—	-40 to 125	°C
		(Note 5)	—	-40 to 85	
Input rise and fall time	dt/dv		$V_{CC} = 1.8 \pm 0.15 \text{ V}, 2.5 \pm 0.2 \text{ V}$	0 to 20	ns/V
			$V_{CC} = 3.3 \pm 0.3 \text{ V}$	0 to 10	
			$V_{CC} = 5.0 \pm 0.5 \text{ V}$	0 to 5	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 1: Data retention only

Note 2:  $V_{CC} = 0 \text{ V}$  or high impedance condition

Note 3: High (H) or Low (L) state.

Note 4: For devices with the ordering part number ending in J(CT).

Note 5: For devices except those with the ordering part number ending in J(CT).

**9. Electrical Characteristics**

**9.1. DC Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Min	Typ.	Max	Unit	
High-level input voltage	$V_{IH}$	—	1.65 to 1.95	$V_{CC} \times 0.75$	—	—	V	
			2.3 to 5.5	$V_{CC} \times 0.70$	—	—		
Low-level input voltage	$V_{IL}$	—	1.65 to 1.95	—	—	$V_{CC} \times 0.25$	V	
			2.3 to 5.5	—	—	$V_{CC} \times 0.30$		
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	1.65	1.55	1.65	—	V
				2.3	2.2	2.3	—	
				3.0	2.9	3.0	—	
				4.5	4.4	4.5	—	
			$I_{OH} = -4\text{ mA}$	1.65	1.29	1.52	—	
				2.3	1.9	2.15	—	
				3.0	2.4	2.8	—	
				4.5	3.8	4.2	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IL}$	$I_{OL} = 100\text{ }\mu\text{A}$	1.65	—	0.0	0.1	V
				2.3	—	0.0	0.1	
				3.0	—	0.0	0.1	
				4.5	—	0.0	0.1	
			$I_{OL} = 4\text{ mA}$	1.65	—	0.08	0.24	
				2.3	—	0.1	0.3	
				3.0	—	0.15	0.4	
				4.5	—	0.22	0.55	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V}$ or GND	0 to 5.5	—	—	$\pm 1$	$\mu\text{A}$	
			1.65 to 5.5	—	—	$\pm 1$		
3-state output OFF-state leakage current	$I_{OZ}$	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to $5.5\text{ V}$	1.65 to 5.5	—	—	$\pm 1$	$\mu\text{A}$	
Power-OFF leakage current	$I_{OFF}$	$V_{IN}$ or $V_{OUT} = 5.5\text{ V}$	0	—	—	1	$\mu\text{A}$	
Quiescent supply current	$I_{CC}$	$V_{IN} = 5.5\text{ V}$ or GND	1.65 to 5.5	—	—	1	$\mu\text{A}$	

**9.2. DC Characteristics (Unless otherwise specified,  $T_a = -40$  to  $85$  °C)**

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Max	Unit
High-level input voltage	$V_{IH}$	—		1.65 to 1.95	$V_{CC} \times 0.75$	—	V
				2.3 to 5.5	$V_{CC} \times 0.70$	—	
Low-level input voltage	$V_{IL}$	—		1.65 to 1.95	—	$V_{CC} \times 0.25$	V
				2.3 to 5.5	—	$V_{CC} \times 0.30$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100 \mu A$	1.65	1.55	—	V
				2.3	2.2	—	
				3.0	2.9	—	
				4.5	4.4	—	
			$I_{OH} = -4$ mA	1.65	1.29	—	
			$I_{OH} = -8$ mA	2.3	1.9	—	
			$I_{OH} = -16$ mA	3.0	2.4	—	
			$I_{OH} = -24$ mA	3.0	2.3	—	
$I_{OH} = -32$ mA	4.5	3.8	—				
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IL}$	$I_{OL} = 100 \mu A$	1.65	—	0.1	V
				2.3	—	0.1	
				3.0	—	0.1	
				4.5	—	0.1	
			$I_{OL} = 4$ mA	1.65	—	0.24	
			$I_{OL} = 8$ mA	2.3	—	0.3	
			$I_{OL} = 16$ mA	3.0	—	0.4	
			$I_{OL} = 24$ mA	3.0	—	0.55	
$I_{OL} = 32$ mA	4.5	—	0.55				
Input leakage current	$I_{IN}$	$V_{IN} = 5.5$ V or GND		0 to 5.5	—	$\pm 10$	$\mu A$
3-state output OFF-state leakage current	$I_{OZ}$	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to $5.5$ V		1.65 to 5.5	—	$\pm 10$	$\mu A$
Power-OFF leakage current	$I_{OFF}$	$V_{IN}$ or $V_{OUT} = 5.5$ V		0	—	10	$\mu A$
Quiescent supply current	$I_{CC}$	$V_{IN} = 5.5$ V or GND		1.65 to 5.5	—	10	$\mu A$

**9.3. DC Characteristics (Note) (Unless otherwise specified,  $T_a = -40$  to  $125$  °C)**

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Min	Max	Unit	
High-level input voltage	$V_{IH}$	—	1.65 to 1.95	$V_{CC} \times 0.75$	—	V	
			2.3 to 5.5	$V_{CC} \times 0.70$	—		
Low-level input voltage	$V_{IL}$	—	1.65 to 1.95	—	$V_{CC} \times 0.25$	V	
			2.3 to 5.5	—	$V_{CC} \times 0.30$		
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100 \mu A$	1.65	1.55	—	V
				2.3	2.2	—	
				3.0	2.9	—	
				4.5	4.4	—	
			$I_{OH} = -4$ mA	1.65	0.95	—	
			$I_{OH} = -8$ mA	2.3	1.7	—	
			$I_{OH} = -16$ mA	3.0	2.2	—	
			$I_{OH} = -24$ mA	3.0	2.0	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IL}$	$I_{OL} = 100 \mu A$	1.65	—	0.1	V
				2.3	—	0.1	
				3.0	—	0.1	
				4.5	—	0.1	
			$I_{OL} = 4$ mA	1.65	—	0.7	
			$I_{OL} = 8$ mA	2.3	—	0.45	
			$I_{OL} = 16$ mA	3.0	—	0.6	
			$I_{OL} = 24$ mA	3.0	—	0.8	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5$ V or GND	0 to 5.5	—	$\pm 20$	$\mu A$	
3-state output OFF-state leakage current	$I_{OZ}$	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to $5.5$ V	1.65 to 5.5	—	$\pm 20$	$\mu A$	
Power-OFF leakage current	$I_{OFF}$	$V_{IN}$ or $V_{OUT} = 5.5$ V	0	—	100	$\mu A$	
Quiescent supply current	$I_{CC}$	$V_{IN} = 5.5$ V or GND	1.65 to 5.5	—	100	$\mu A$	

Note: For devices with the ordering part number ending in J(CT).

**9.4. AC Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )**

Characteristics	Symbol	Note	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Typ.	Max	Unit
Propagation delay time	$t_{PLH}, t_{PHL}$		$R_L = 1\text{ M}\Omega$ See 9.7 AC Test Circuit, Table 9.7.1	15	15	2.0	5.3	11.0	ns
						0.8	3.4	7.5	
						0.5	2.5	5.2	
						0.5	2.1	4.5	
			$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	1.5	3.2	5.7	ns
						0.8	2.6	5.0	
Output enable time	$t_{PZL}, t_{PZH}$		$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	2.0	7.0	14.9	ns
						1.5	4.6	8.5	
						1.5	3.5	6.2	
						0.8	2.8	5.5	
Output disable time	$t_{PLZ}, t_{PHZ}$		$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	2.0	5.4	11.8	ns
						1.5	4.0	8.0	
						1.0	3.5	5.7	
						0.5	2.5	4.7	
Input capacitance	$C_{IN}$		—	0 to 5.5	—	—	4	—	pF
Output capacitance	$C_{OUT}$		—	0 to 5.5	—	—	4	—	pF
Power dissipation capacitance	$C_{PD}$	(Note 1)	—	3.3	—	—	17	—	pF
				5.5	—	—	24	—	

Note 1:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per 1 bit)}$$

**9.5. AC Characteristics (Unless otherwise specified,  $T_a = -40\text{ to }85\text{ }^\circ\text{C}$ , Input:  $t_r = t_f = 3\text{ ns}$ )**

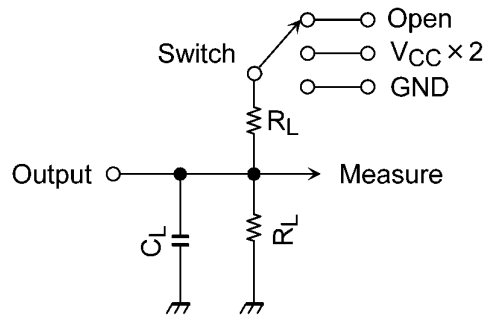
Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit
Propagation delay time	$t_{PLH}, t_{PHL}$	$R_L = 1\text{ M}\Omega$ See 9.7 AC Test Circuit, Table 9.7.1	15	15	2.0	11.5	ns
					0.8	8.0	
					0.5	5.5	
					0.5	4.8	
		$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	1.5	6.0	ns
					0.8	5.3	
Output enable time	$t_{PZL}, t_{PZH}$	$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	2.0	16.6	ns
					1.5	9.0	
					1.5	6.5	
					0.8	5.8	
Output disable time	$t_{PLZ}, t_{PHZ}$	$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	50	50	2.0	12.7	ns
					1.5	8.5	
					1.0	6.0	
					0.5	5.0	

**9.6. AC Characteristics (Note)**  
 (Unless otherwise specified,  $T_a = -40$  to  $125$  °C, Input:  $t_r = t_f = 3$  ns)

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit					
Propagation delay time	$t_{PLH}, t_{PHL}$	$R_L = 1\text{ M}\Omega$ See 9.7 AC Test Circuit, Table 9.7.1	$1.8 \pm 0.15$	15	2.0	13.0	ns					
			$2.5 \pm 0.2$		0.8	9.0						
			$3.3 \pm 0.3$		0.5	6.5						
			$5.0 \pm 0.5$		0.5	5.5						
		$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	$3.3 \pm 0.3$	50	1.5	7.0	ns					
			$5.0 \pm 0.5$		0.8	6.0						
			Output enable time		$t_{PZL}, t_{PZH}$	$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1		$1.8 \pm 0.15$	50	2.0	18.5	ns
								$2.5 \pm 0.2$		1.5	10.0	
$3.3 \pm 0.3$	1.5	7.5										
$5.0 \pm 0.5$	0.8	6.5										
$R_L = 500\ \Omega$ See 9.7 AC Test Circuit, Table 9.7.1	$1.8 \pm 0.15$	50		2.0		14.0	ns					
	$2.5 \pm 0.2$			1.5		9.5						
	$3.3 \pm 0.3$			1.0		7.0						
	$5.0 \pm 0.5$			0.5		5.5						

Note: For devices with the ordering part number ending in J(CT).

**9.7. AC Test Circuit**



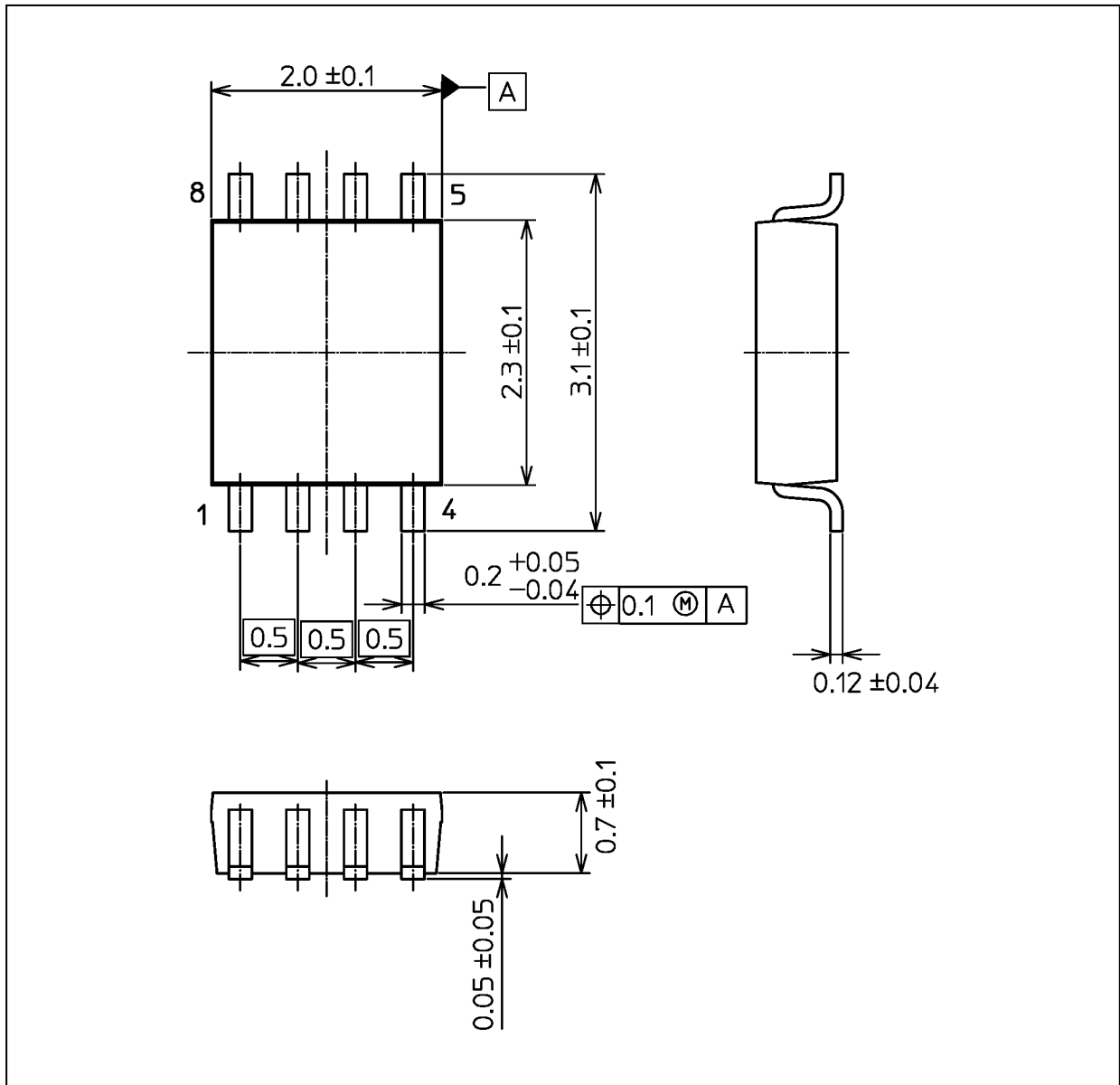
**Table 9.7.1 Parameter for AC Test Circuit**

Characteristics	Switch
$t_{PLH}, t_{PHL}$	Open
$t_{PLZ}, t_{PZL}$	$V_{CC} \times 2$
$t_{PHZ}, t_{PZH}$	GND



Package Dimensions

Unit: mm



Weight: 0.01 g (typ.)

Package Name(s)
JEDEC: SOT-765
Nickname: US8

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